IGBT

2PG001

N-channel enhancement mode IGBT

For plasma display panel drive For high speed switching circuits

Features

- Low collector-emitter saturation voltage: $V_{CE(sat)} < 2.5 \text{ V}$
- High speed hall time: $t_f = 250$ nsec(typ.)

Absolute Maximum Ratings $T_C = 25^{\circ}C$

Parameter	Symbol	Rating	Unit
Collector-emitter voltage (E-B short)	V _{CES}	300	V
Gate-emitter voltage (E-B short)	V _{GES}	±30	V
Collector current	I _C	30	А
Peak collector current *	I _{CP}	120	А
De la l'actuation	P _C	40	W
Power dissipation $T_a = 25^{\circ}C$		2.0	W
Junction temperature	Tj	150	°C
Storage temperature	T _{stg}	-55 to +150	°C

- Package
- Code
- TO-220F-A1
- Marking Symbol: 2PG001
- Pin Name
- 1. Gate
- 2. Collector
- 3. Emitter

Internal Connection

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Note)	*: $PW \le 10$	us, Duty $\leq 1.0\%$
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Electrical Characteristics $T_C = 25^{\circ}C \pm 3^{\circ}C$

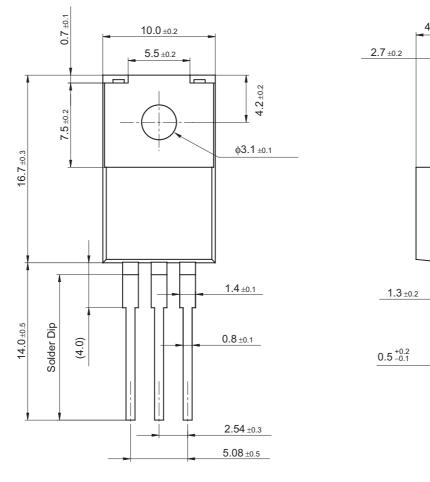
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage (E-B short)	V _{CES}	$I_{\rm C} = 1 {\rm mA}, V_{\rm GE} = 0$	300			V
Collector-emitter cutoff current (E-B short)	I _{CES}	$V_{CE} = 240 \text{ V}, V_{GE} = 0$			50	μΑ
Gate-emitter cutoff current (E-B short)	I _{GES}	$V_{GE} = \pm 30 \text{ V}, V_{CE} = 0$			±1.0	μΑ
Gate-emitter threshold voltage	V _{GE(th)}	$V_{CE} = 10 \text{ V}, I_C = 1.0 \text{ mA}$	3.0		5.5	V
Collector-emitter saturation voltage	V _{CE(sat)}	$V_{GE} = 15 \text{ V}, I_C = 30 \text{ A}$		2.0	2.5	V
Short-circuit input capacitance (Common emitter)	C _{ies}	$V_{CE} = 25 \text{ V}, V_{GE} = 0, f = 1 \text{ MHz}$		580		pF
Short-circuit output capacitance (Common emitter)	C _{oes}			86		pF
Reverse transfer capacitance (Common emitter)	C _{res}			14		pF
Gate charge load	Qg			25		nC
Gate-emitter charge	Q _{ge}	$V_{\rm CC} = 150 \text{ V}, I_{\rm C} = 30 \text{ A}, V_{\rm GE} = 15 \text{ V}$		5		nC
Gate-collector charge	Q _{gc}			10		nC
Turn-on delay time	t _{d(on)}			87		ns
Rise time	t _r	$V_{\rm CC} = 150 \text{ V}, I_{\rm C} = 30 \text{ A},$		400		ns
Turn-off delay time	t _{d(off)}	$RL \approx 5 \Omega$, $V_{GE} = 15 V$		120		ns
Fall time	t _f	1		150		ns

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

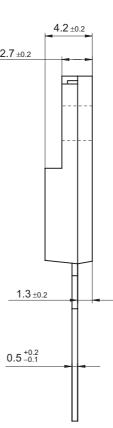
Panasonic

TO-220F-A1

Unit: mm



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